

# High Temperature Superconductor Lead Assemblies for XRISM

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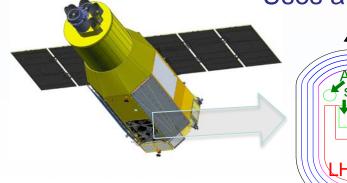
<sup>1</sup> NASA – Goddard Space Flight Center

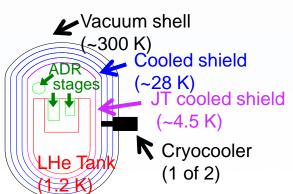
# **Background: RESOLVE**

RESOLVE: soft x-ray spectrometer on XRISM (X-Ray Imaging and Spectroscopy Mission)

Rebuild of SXS instrument on Astro-H — no changes except where necessary

Uses a microcalorimeter array operating at 50 mK





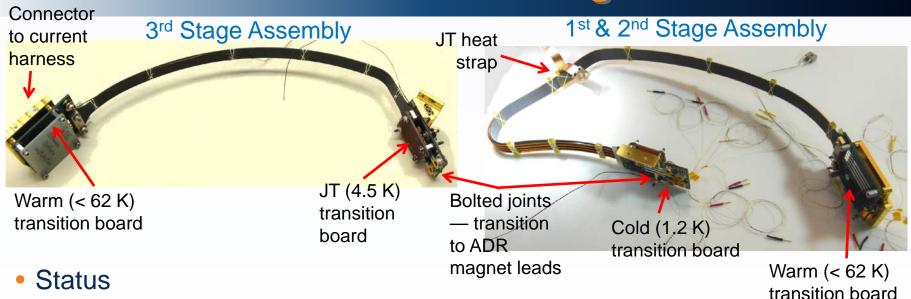
#### RESOLVE Thermal System:

- (2x) 2 stage Stirling coolers
- JT cooler (4.5 K)
- 40 I LHe tank (1.2 K)
- 3 stage ADR ( 50 mK )

## **Background: HTS Lead Assemblies**

- High Temperature Superconductor Lead Assemblies necessary to carry high current to 3 ADR magnets
- Driving requirements:
  - 2 Amp maximum on each of 3 circuits @ up to 62 K warm end
  - < 12 μWatt total conducted heat leak to 1.3 K</p>
  - < 10  $\mu\Omega$  per circuit total resistance at cold end (bolted and solder joints)

# **HTS Lead Assemblies — Configuration**



- Engineering Model complete
- Flight Model 1 fabricated and fully verified
- Flight Model 2 fabricated; pre-vibe testing complete

## **Solder Joints: Material Changes**

- HTS tape
  - SXS: AuAg alloy coated tape; slit to 1 mm after production (open sides)
  - RESOLVE:
    - Slit to 1 mm, then sputter coated with AuAg (all sides)
    - Individual sections cut and plated over solder region with > 20 µm Cu
    - Section  $I_c$ 's measured to 20 Amperes:
      - 37 of 48 long (590 mm), 21 of 24 short (335 mm) sections ≥ 20 A;
      - All  $I_c$ 's ≥ 16 A
- Solder
  - In3%Ag (SXS) → In48%Sn (RESOLVE)
    - Lower  $T_{melt}$  (144 C  $\rightarrow$  118 C)

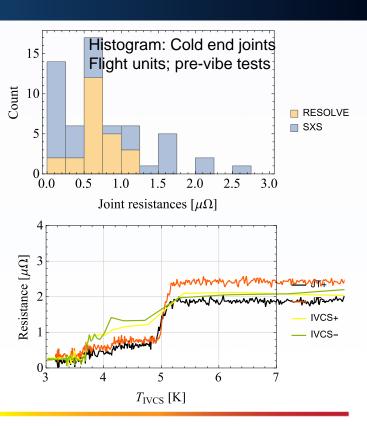
## Solder Joints: Process Changes

- Solder rig
  - Precise control over pressure, temperature, & time
  - Changes for flight boards:
    - Custom soldering tips match joint length
    - Wires & bobbins act act as cooling fins → added secondary heaters to cancel effect



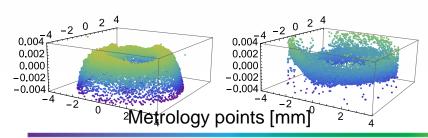
#### **Solder Joints: Results**

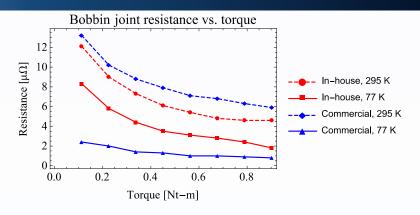
- Improved Consistency:
  - Compared all pre-vibe qualification tests: I-V measurement to 5 Amps, cold end at 4.5 K
  - Cold end solder joint resistances much more uniform
  - No values > 1.1  $\mu\Omega$
  - Similar results for warm end (62 K)
- Very low resistance at low T
  - Bridge (low current) measurements show transitions at ~5.0, ~3.7 K
  - Below 3.7 K, R < 0.4  $\mu\Omega$



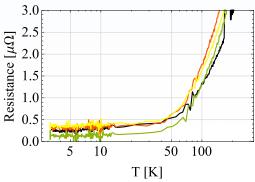
# **Bolted Joints: Changes and Results**

Bobbins:	In-house	Commercial
Cu material:	99.999%	CU101
Au Plating	Ni flash, Thick Au	No Ni flash, Standard thickness
Fabrication	EDM, polished	Lathe
Metrology:	rounded	Flat,+ ridge





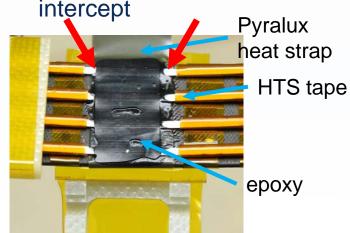
Result: Bolted joint resistance now typically < 0.5  $\mu\Omega$  at low T



# 1<sup>st</sup> & 2<sup>nd</sup> Stage Thermal Intercept: Changes

HTS tapes in 1<sup>st</sup>&2<sup>nd</sup> Stage unit must be well heat sunk to JT shield

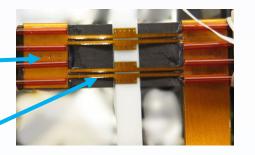
Concern over stress concentration at JT thermal

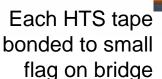


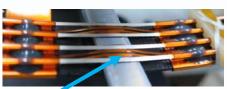
New strap design:

Multilayer Pyralux strap

Compliant bridge for each HTS tape





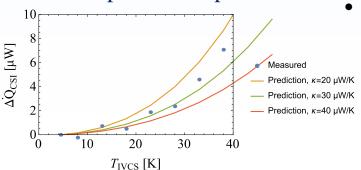


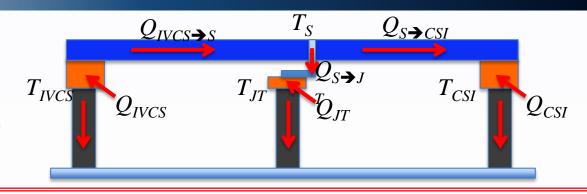
# 1<sup>st</sup> & 2<sup>nd</sup> Stage Thermal Intercept: Results

- Measurement:
  - Control  $T_{\text{IVCS}}$ ,  $T_{\text{JT}} = T_{\text{CSI}}$
  - Measure  $\Delta Q_{CSI}$  vs  $T_{IVCS}$
- If strap conductance,  $\kappa \to \infty$

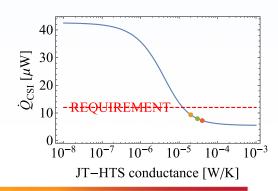
$$T_{s} = T_{JT} = T_{CSI} \rightarrow \Delta Q_{CSI} = Q_{s \rightarrow CSI} = 0$$

• With imperfect strap:





- 1-D Conduction-only model
- For flight condition  $(T_{IVCS} = 28 \text{ K}, T_{JT} = 4.5 \text{ K}, T_{CSI} = 1.3 \text{ K})$ , heat leak to CSI:



#### Conclusions

- HTS Lead Assemblies for RESOLVE instrument largely rebuild, except
- Solder joints:
  - New tape and solder
  - Tighter solder process control
  - Result: much more consistent solder joint resistances
- Bolted joints:
  - Initial testing lead to change to commercial bobbins
  - Pre-assembly screening
  - Result: much more consistent and lower bolted joint resistances
- JT heat intercept:
  - New design eliminates concern over stress concentration
  - Improved thermal test apparatus allows determination of 1<sup>st</sup> & 2<sup>nd</sup> Stage parasitic conductance
- Overall, RESOLVE HTS lead assemblies meet their requirements with significantly better margin than the Hitomi/SXS units